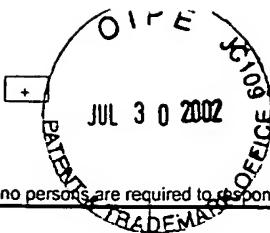


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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Application Number	10/086,137
		Filing Date	February 26, 2002
		First Named Inventor	Zhang, et al.
		Group Art Unit	2881
		Examiner Name	N/A
		Attorney Docket Number	NUFO-011
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U.S. PATENT DOCUMENTS						
Examiner Initials ¹	Cite No. ¹	U.S. Patent Documents		Name of Patentee or Applicant of Cited Documents	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
TN		6,404,798		Leckel et al.	06/11/02	

FOREIGN PATENT DOCUMENTS								
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TN		Carl E. Wieman "Using Diode Lasers for Atomic Physics" Review Article, Rev. Sci. Instrum 62(1), January 1991; pp 1-20	
TN		Leckel, et al., "Impact of Source Spontaneous Emission (SSE) on the Measurement of DWDM Components" Trends in Optics and Photonics, Tops Vol. 37, March 7-10, 2002, pp 31-33	
TN		Fulop et al., "High Power A-S-E-free Tunable Laser Using a Sagnac Ring Interferometer within the External Cavity" Optical Fiber Communication Conference and Exhibit, March 17-22, 2001 Technical Digest, TuJ6-1-3	

Examiner Signature		Date Considered	7/17/03
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